# KSE10N03

## 100V N-Channel MOSFET

### General Description

*The KSE10N03 is the high cell density trenched N-ch MOSFET, which provides excellent $R_{DS}ON$ and efficiency for most of the small power switching and load switch applications.*

*The KSE10N03 meet the RoHS and Green Product requirement with full function reliability approved.*

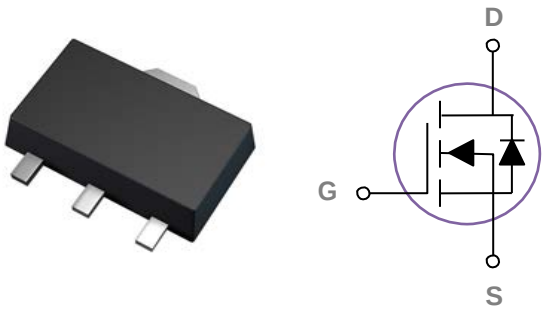
### Product Summary

| $V_{DS}$ (V) | $R_{DS}$(on) (mΩ) | $I_D$ (A) |
|---|---|---|
| 100 | 106 at $V_{GS}$ = 10 V | 3.0 |
| | 115 at$V_{GS}$ = 4.5 V | 2.5 |

### Features

- *Super Low Gate Charge*
- *Excellent Cdv/dt effect decline*
- *Excellent package for good heat dissipation*

### **SOT89** Pin Configuration




### Applications

- *Power switching application*
- *industrial power supplies*
- *LED backlighting*

***100% UIS TESTED!***
***100% ΔVds TESTED!***

### Absolute Maximum Ratings $T_C$=25℃ unless otherwise noted

| Symbol | Parameter | Rating | Units |
|---|---|---|---|
| $V_{DS}$ | Drain-Source Voltage | 100 | V |
| $V_{GS}$ | Gate-Source Voltage | ±20 | V |
| $I_D$ | Drain Current – Continuous ($T_C$=25℃) | 3.0 | A |
| | Drain Current – Continuous ($T_C$=100℃) | 1.4 | A |
| $I_{DM}$ | Drain Current – Pulsed[1] | 15 | A |
| $P_D$ | Power Dissipation ($T_C$=25℃) | 2.4 | W |
| | Power Dissipation – Derate above 25℃ | 0.3 | W/℃ |
| $T_{STG}$ | Storage Temperature Range | -55 to 150 | ℃ |
| $T_J$ | Operating Junction Temperature Range | -55 to 150 | ℃ |

### Thermal Characteristics

| Symbol | Parameter | Typ. | Max. | Unit |
|---|---|---|---|---|
| $R_{\theta JA}$ | Thermal Resistance Junction to ambient | --- | 61 | ℃/W |
| $R_{\theta JC}$ | Thermal Resistance Junction to Case | --- | 3.2 | ℃/W |

## Electrical Characteristics ($T_J$=25 ℃, unless otherwise noted)

### Off Characteristics

| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Unit |
|---|---|---|---|---|---|---|
| $BV_{DSS}$ | Drain-Source Breakdown Voltage | $V_{GS}$=0V , $I_D$=250uA | 100 | --- | --- | V |
| $\triangle BV_{DSS}/\triangle T_J$ | $BV_{DSS}$ Temperature Coefficient | Reference to 25℃ , $I_D$=1mA | --- | 0.01 | --- | V/℃ |
| $I_{DSS}$ | Drain-Source Leakage Current | $V_{DS}$=50V , $V_{GS}$=0V , $T_J$=25℃ | --- | --- | 1 | uA |
| | | $V_{DS}$=50V , $V_{GS}$=0V , $T_J$=125℃ | --- | --- | 10 | uA |
| $I_{GSS}$ | Gate-Source Leakage Current | $V_{GS}$=±20V , $V_{DS}$=0V | --- | --- | ±100 | nA |

### On Characteristics

| | | | | | | |
|---|---|---|---|---|---|---|
| $R_{DS(ON)}$ | Static Drain-Source On-Resistance | $V_{GS}$=10V , $I_D$=3.0A | --- | 106 | 134 | mΩ |
| | | $V_{GS}$=4.5V , $I_D$=1.5A | --- | 115 | 142 | mΩ |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{GS}$=$V_{DS}$ , $I_D$ =250uA | 1.0 | 1.68 | 2.7 | V |
| $\triangle V_{GS(th)}$ | $V_{GS(th)}$ Temperature Coefficient | | --- | 1.6 | --- | mV/℃ |
| gfs | Forward Transconductance | $V_{DS}$=10V , $I_S$=2A | --- | 16 | --- | S |

### Dynamic and switching Characteristics

| | | | | | | |
|---|---|---|---|---|---|---|
| $Q_g$ | Total Gate Charge[2,3] | $V_{DS}$=50V , $V_{GS}$=10V , $I_D$=2A | --- | 8.7 | 15 | nC |
| $Q_{gs}$ | Gate-Source Charge[2,3] | | --- | 1.4 | 3.0 | |
| $Q_{gd}$ | Gate-Drain Charge[2,3] | | --- | 2.4 | 4.0 | |
| $T_{d(on)}$ | Turn-On Delay Time[2,3] | $V_{DS}$=50V , $V_{GS}$=10V , $R_G$=3.3 Ω $I_D$=1A | --- | 7.6 | 13 | ns |
| $T_r$ | Rise Time[2,3] | | --- | 3.3 | 6 | |
| $T_{d(off)}$ | Turn-Off Delay Time[2,3] | | --- | 28 | 37 | |
| $T_f$ | Fall Time[2,3] | | --- | 6.2 | 9 | |
| $C_{iss}$ | Input Capacitance | $V_{DS}$=15V , $V_{GS}$=0V , F=1MHz | --- | 850 | 1057 | pF |
| $C_{oss}$ | Output Capacitance | | --- | 56 | 75 | |
| $C_{rss}$ | Reverse Transfer Capacitance | | --- | 30 | 50 | |

### Drain-Source Diode Characteristics and Maximum Ratings

| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Unit |
|---|---|---|---|---|---|---|
| $I_S$ | Continuous Source Current | $V_G$=$V_D$=0V , Force Current | --- | --- | 3.0 | A |
| $I_{SM}$ | Pulsed Source Current | | --- | --- | 15 | A |
| $V_{SD}$ | Diode Forward Voltage | $V_{GS}$=0V , $I_S$=1A , $T_J$=25℃ | --- | --- | 1.2 | V |

Note :
1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
2. The data tested by pulsed , pulse width ≦ 300us , duty cycle ≦ 2%.
3. Essentially independent of operating temperature.

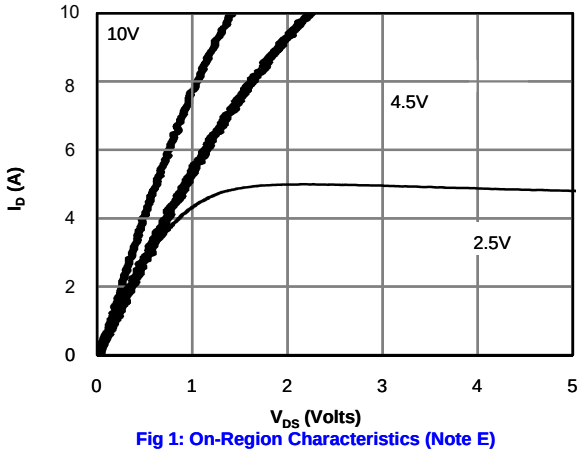



Fig 1: On-Region Characteristics (Note E)

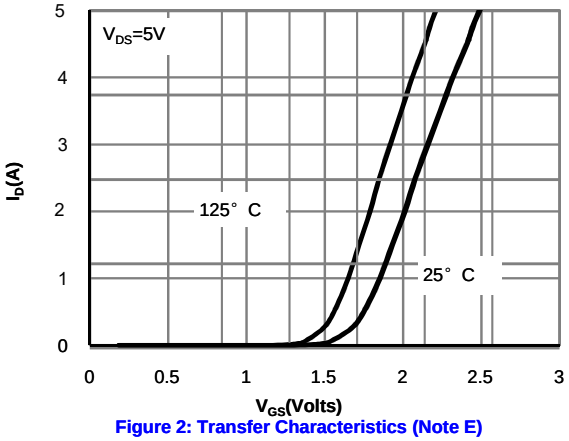



Figure 2: Transfer Characteristics (Note E)

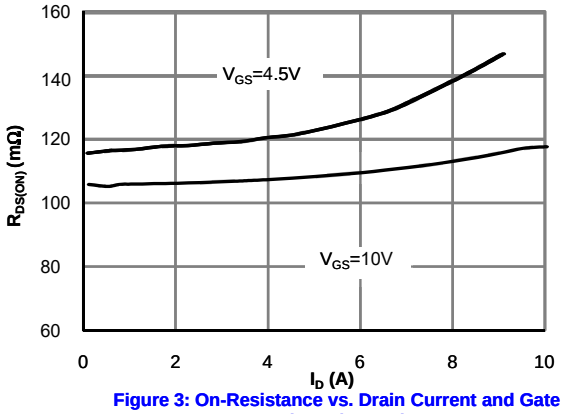



Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

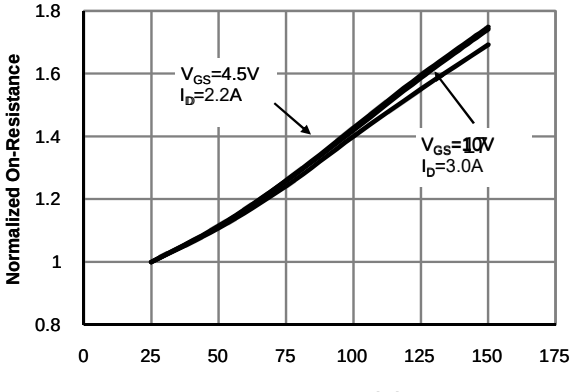



Figure 4: On-Resistance vs. Junction Temperature (Note E)

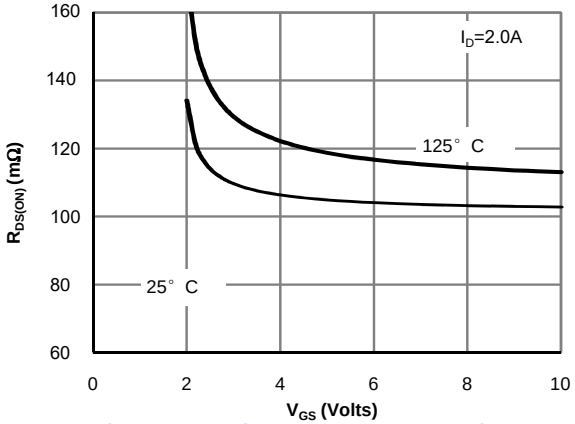



Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

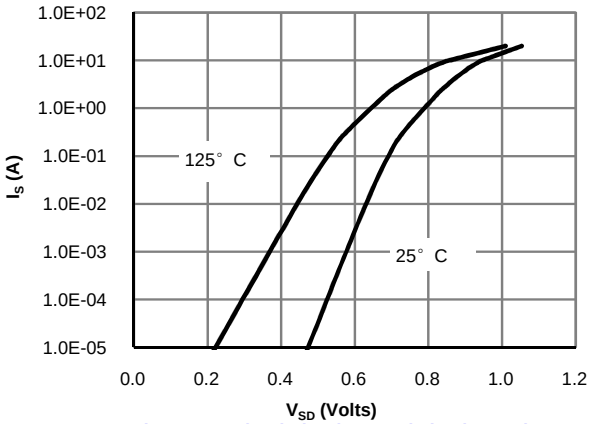



Figure 6: Body-Diode Characteristics (Note E)

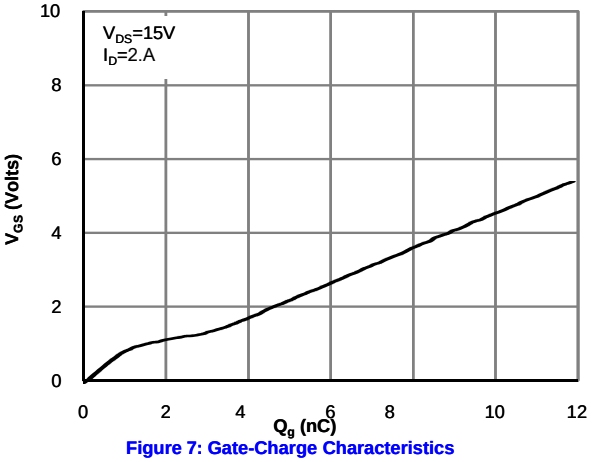



Figure 7: Gate-Charge Characteristics

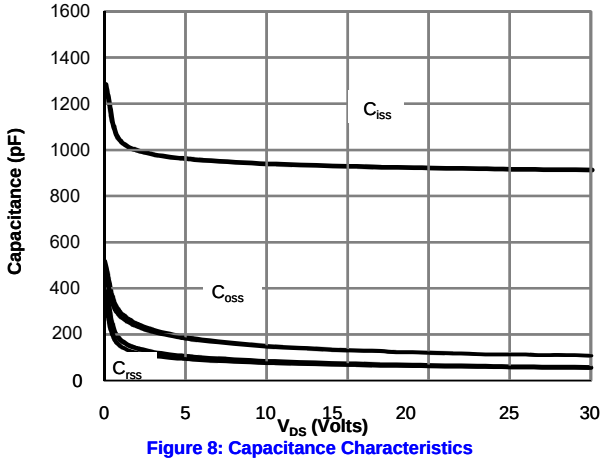



Figure 8: Capacitance Characteristics

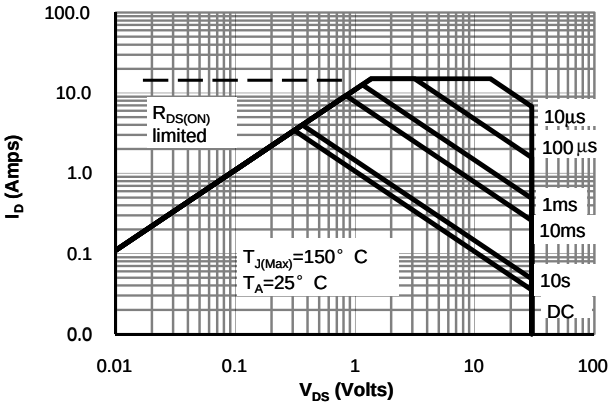



Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

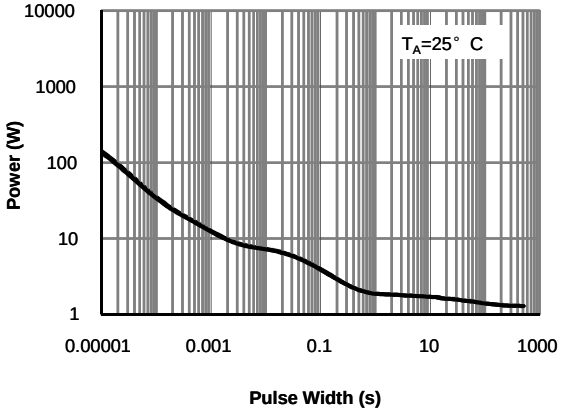



Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note F)

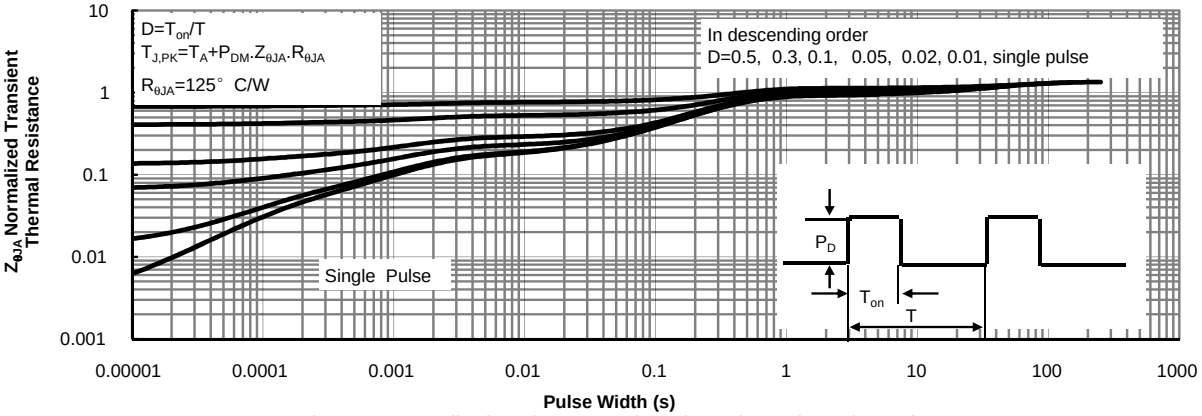



Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

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